Notice of References Cited Application/Control No. 10/582,464 Examiner Devina Pillay Applicant(s)/Patent Under Reexamination GEYER ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
*	Α	US-6,126,740	10-2000	Schulz et al.	117/4	
*	В	US-2005/0119132 A1	06-2005	Xu et al.	505/100	
	С	US-				
	D	US-				
	Е	US-				
	F	US-				
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	ı	US-	6			
	J	US-				
	К	US-	()			
	L	US-				
	М	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
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	s					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

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